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MCF5213 Family Configurations

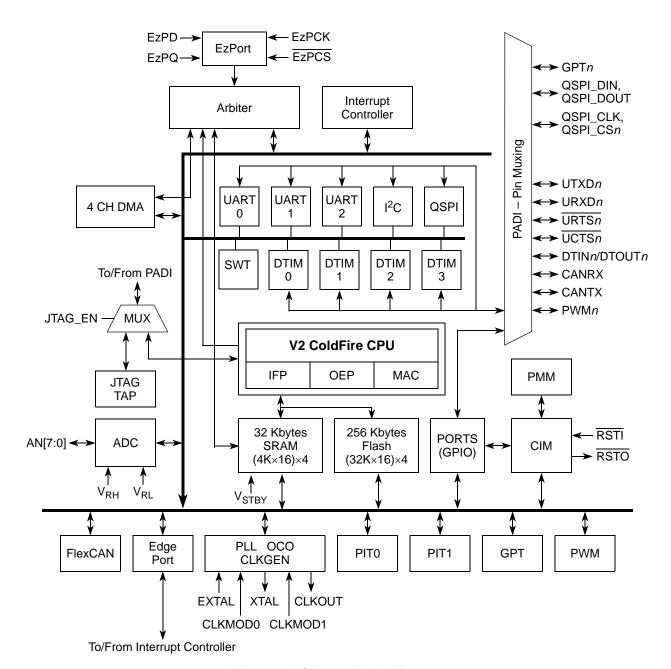


Figure 1. MCF5213 Block Diagram

1.1 Features

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1.1.1 Feature Overview

The MCF5213 family includes the following features:



- Version 2 ColdFire variable-length RISC processor core
 - Static operation
 - 32-bit address and data paths on-chip
 - Up to 80 MHz processor core frequency
 - Sixteen general-purpose, 32-bit data and address registers
 - Implements ColdFire ISA_A with extensions to support the user stack pointer register and four new instructions for improved bit processing (ISA_A+)
 - Multiply-Accumulate (MAC) unit with 32-bit accumulator to support $16 \times 16 \rightarrow 32$ or $32 \times 32 \rightarrow 32$ operations
 - Illegal instruction decode that allows for 68-Kbyte emulation support
- System debug support
 - Real-time trace for determining dynamic execution path
 - Background debug mode (BDM) for in-circuit debugging (DEBUG_B+)
 - Real-time debug support, with six hardware breakpoints (4 PC, 1 address and 1 data) configurable into a 1- or 2-level trigger
- On-chip memories
 - 32-Kbyte dual-ported SRAM on CPU internal bus, supporting core and DMA access with standby power supply support
 - 256 Kbytes of interleaved flash memory supporting 2-1-1-1 accesses
- Power management
 - Fully static operation with processor sleep and whole chip stop modes
 - Rapid response to interrupts from the low-power sleep mode (wake-up feature)
 - Clock enable/disable for each peripheral when not used
- FlexCAN 2.0B module
 - Based on and includes all existing features of the Freescale TouCAN module
 - Full implementation of the CAN protocol specification version 2.0B
 - Standard data and remote frames (up to 109 bits long)
 - Extended data and remote frames (up to 127 bits long)
 - Zero to eight bytes data length
 - Programmable bit rate up to 1 Mbit/sec
 - Flexible message buffers (MBs), totalling up to 16 message buffers of 0–8 byte data length each, configurable as Rx or Tx, all supporting standard and extended messages
 - Unused MB space can be used as general purpose RAM space
 - Listen-only mode capability
 - Content-related addressing
 - No read/write semaphores
 - Three programmable mask registers: global for MBs 0-13, special for MB14, and special for MB15
 - Programmable transmit-first scheme: lowest ID or lowest buffer number
 - Time stamp based on 16-bit free-running timer
 - Global network time, synchronized by a specific message
 - Maskable interrupts
- Three universal asynchronous/synchronous receiver transmitters (UARTs)
 - 16-bit divider for clock generation
 - Interrupt control logic with maskable interrupts
 - DMA support
 - Data formats can be 5, 6, 7 or 8 bits with even, odd, or no parity
 - Up to two stop bits in 1/16 increments

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1.1.4 **JTAG**

The MCF5213 supports circuit board test strategies based on the Test Technology Committee of IEEE and the Joint Test Action Group (JTAG). The test logic includes a test access port (TAP) consisting of a 16-state controller, an instruction register, and three test registers (a 1-bit bypass register, a 256-bit boundary-scan register, and a 32-bit ID register). The boundary scan register links the device's pins into one shift register. Test logic, implemented using static logic design, is independent of the device system logic.

The MCF5213 implementation can:

- Perform boundary-scan operations to test circuit board electrical continuity
- Sample MCF5213 system pins during operation and transparently shift out the result in the boundary scan register
- Bypass the MCF5213 for a given circuit board test by effectively reducing the boundary-scan register to a single bit
- Disable the output drive to pins during circuit-board testing
- Drive output pins to stable levels

1.1.5 **On-Chip Memories**

1.1.5.1 SRAM

The dual-ported SRAM module provides a general-purpose 32-Kbyte memory block that the ColdFire core can access in a single cycle. The location of the memory block can be set to any 32-Kbyte boundary within the 4-Gbyte address space. This memory is ideal for storing critical code or data structures and for use as the system stack. Because the SRAM module is physically connected to the processor's high-speed local bus, it can quickly service core-initiated accesses or memory-referencing commands from the debug module.

The SRAM module is also accessible by the DMA. The dual-ported nature of the SRAM makes it ideal for implementing applications with double-buffer schemes, where the processor and a DMA device operate in alternate regions of the SRAM to maximize system performance.

1.1.5.2 Flash Memory

The ColdFire flash module (CFM) is a non-volatile memory (NVM) module that connects to the processor's high-speed local bus. The CFM is constructed with four banks of 32-Kbyte×16-bit flash memory arrays to generate 256 Kbytes of 32-bit flash memory. These electrically erasable and programmable arrays serve as non-volatile program and data memory. The flash memory is ideal for program and data storage for single-chip applications, allowing for field reprogramming without requiring an external high voltage source. The CFM interfaces to the ColdFire core through an optimized read-only memory controller that supports interleaved accesses from the 2-cycle flash memory arrays. A backdoor mapping of the flash memory is used for all program, erase, and verify operations, as well as providing a read datapath for the DMA. Flash memory may also be programmed via the EzPort, which is a serial flash memory programming interface that allows the flash memory to be read, erased and programmed by an external controller in a format compatible with most SPI bus flash memory chips.

1.1.6 Power Management

The MCF5213 incorporates several low-power modes of operation entered under program control and exited by several external trigger events. An integrated power-on reset (POR) circuit monitors the input supply and forces an MCU reset as the supply voltage rises. The low voltage detector (LVD) monitors the supply voltage and is configurable to force a reset or interrupt condition if it falls below the LVD trip point. The RAM standby switch provides power to RAM when the supply voltage to the chip falls below the standby battery voltage.

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1.1.7 FlexCAN

The FlexCAN module is a communication controller implementing version 2.0 of the CAN protocol parts A and B. The CAN protocol can be used as an industrial control serial data bus, meeting the specific requirements of reliable operation in a harsh EMI environment with high bandwidth. This instantiation of FlexCAN has 16 message buffers.

1.1.8 **UARTs**

The MCF5213 has three full-duplex UARTs that function independently. The three UARTs can be clocked by the system bus clock, eliminating the need for an external clock source. On smaller packages, the third UART is multiplexed with other digital I/O functions.

1.1.9 I²C Bus

The I²C bus is a two-wire, bidirectional serial bus that provides a simple, efficient method of data exchange and minimizes the interconnection between devices. This bus is suitable for applications requiring occasional communications over a short distance between many devices.

1.1.10 QSPI

The queued serial peripheral interface (QSPI) provides a synchronous serial peripheral interface with queued transfer capability. It allows up to 16 transfers to be queued at once, minimizing the need for CPU intervention between transfers.

1.1.11 Fast ADC

The fast ADC consists of an eight-channel input select multiplexer and two independent sample and hold (S/H) circuits feeding separate 12-bit ADCs. The two separate converters store their results in accessible buffers for further processing.

The ADC can be configured to perform a single scan and halt, a scan when triggered, or a programmed scan sequence repeatedly until manually stopped.

The ADC can be configured for sequential or simultaneous conversion. When configured for sequential conversions, up to eight channels can be sampled and stored in any order specified by the channel list register. Both ADCs may be required during a scan, depending on the inputs to be sampled.

During a simultaneous conversion, both S/H circuits are used to capture two different channels at the same time. This configuration requires that a single channel may not be sampled by both S/H circuits simultaneously.

Optional interrupts can be generated at the end of the scan sequence if a channel is out of range (measures below the low threshold limit or above the high threshold limit set in the limit registers) or at several different zero crossing conditions.

1.1.12 DMA Timers (DTIM0-DTIM3)

There are four independent, DMA transfer capable 32-bit timers (DTIM0, DTIM1, DTIM2, and DTIM3) on the MCF5213. Each module incorporates a 32-bit timer with a separate register set for configuration and control. The timers can be configured to operate from the system clock or from an external clock source using one of the DTINn signals. If the system clock is selected, it can be divided by 16 or 1. The input clock is further divided by a user-programmable 8-bit prescaler that clocks the actual timer counter register (TCRn). Each of these timers can be configured for input capture or reference (output) compare mode. Timer events may optionally cause interrupt requests or DMA transfers.



1.1.13 General Purpose Timer (GPT)

The general purpose timer (GPT) is a four-channel timer module consisting of a 16-bit programmable counter driven by a seven-stage programmable prescaler. Each of the four channels can be configured for input capture or output compare. Additionally, channel three, can be configured as a pulse accumulator.

A timer overflow function allows software to extend the timing capability of the system beyond the 16-bit range of the counter. The input capture and output compare functions allow simultaneous input waveform measurements and output waveform generation. The input capture function can capture the time of a selected transition edge. The output compare function can generate output waveforms and timer software delays. The 16-bit pulse accumulator can operate as a simple event counter or a gated time accumulator.

1.1.14 Periodic Interrupt Timers (PIT0 and PIT1)

The two periodic interrupt timers (PIT0 and PIT1) are 16-bit timers that provide interrupts at regular intervals with minimal processor intervention. Each timer can count down from the value written in its PIT modulus register or it can be a free-running down-counter.

1.1.15 Pulse-Width Modulation (PWM) Timers

The MCF5213 has an 8-channel, 8-bit PWM timer. Each channel has a programmable period and duty cycle as well as a dedicated counter. Each of the modulators can create independent continuous waveforms with software-selectable duty rates from 0% to 100%. The PWM outputs have programmable polarity, and can be programmed as left aligned outputs or center aligned outputs. For higher period and duty cycle resolution, each pair of adjacent channels ([7:6], [5:4], [3:2], and [1:0]) can be concatenated to form a single 16-bit channel. The module can, therefore, be configured to support 8/0, 6/1, 4/2, 2/3, or 0/4 8-/16-bit channels.

1.1.16 Software Watchdog Timer

The watchdog timer is a 32-bit timer that facilitates recovery from runaway code. The watchdog counter is a free-running down-counter that generates a reset on underflow. To prevent a reset, software must periodically restart the countdown.

1.1.17 Phase-Locked Loop (PLL)

The clock module contains a crystal oscillator, 8 MHz on-chip relaxation oscillator (OCO), phase-locked loop (PLL), reduced frequency divider (RFD), low-power divider status/control registers, and control logic. To improve noise immunity, the PLL, crystal oscillator, and relaxation oscillator have their own power supply inputs: VDDPLL and VSSPLL. All other circuits are powered by the normal supply pins, VDD and VSS.

1.1.18 Interrupt Controller (INTC)

The MCF5213 has a single interrupt controller that supports up to 63 interrupt sources. There are 56 programmable sources, 49 of which are assigned to unique peripheral interrupt requests. The remaining seven sources are unassigned and may be used for software interrupt requests.

1.1.19 DMA Controller

The direct memory access (DMA) controller provides an efficient way to move blocks of data with minimal processor intervention. It has four channels that allow byte, word, longword, or 16-byte burst line transfers. These transfers are triggered by software explicitly setting a DCRn[START] bit or by the occurrence of certain UART or DMA timer events.

NP

Table 3. Pin Functions by Primary and Alternate Purpose

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength / Control ¹	Slew Rate / Control ¹	Pull-up / Pull-down ²	Pin on 100 LQFP	Pin on 81 MAPBGA	Pin on 64 LQFP/QFN
ADC	AN7	_	_	GPIO	Low	FAST	_	51	H9	33
	AN6	_	_	GPIO	Low	FAST	_	52	G9	34
	AN5	_	_	GPIO	Low	FAST	_	53	G8	35
	AN4	_		GPIO	Low	FAST	_	54	F9	36
	AN3	_		GPIO	Low	FAST	_	46	G7	28
	AN2	_		GPIO	Low	FAST	_	45	G6	27
	AN1	_		GPIO	Low	FAST	_	44	H6	26
	AN0	_		GPIO	Low	FAST	_	43	J6	25
	SYNCA ³	_		_	N/A	N/A	_	_	_	_
	SYNCB ³			_	N/A	N/A	_	_	_	_
	VDDA	_		_	N/A	N/A	_	50	H8	32
	VSSA	_		_	N/A	N/A	_	47	H7, J9	29
	VRH	_		_	N/A	N/A	_	49	J8	31
	VRL	_		_	N/A	N/A	_	48	J7	30
Clock	EXTAL	_		_	N/A	N/A	_	73	B9	47
Generation	XTAL	_		_	N/A	N/A	_	72	C9	46
	VDDPLL	_		_	N/A	N/A	_	74	B8	48
	VSSPLL	_		_	N/A	N/A	_	71	C8	45
Debug Data	ALLPST	_	_	_	High	FAST	_	86	A6	55
	DDATA[3:0]	_	_	GPIO	High	FAST	_	84,83,78,77	_	_
	PST[3:0]	_	_	GPIO	High	FAST	_	70,69,66,65	_	_
I ² C	SCL	CANTX ⁴	UTXD2	GPIO	PDSR[0]	PSRR[0]	pull-up ⁵	10	E1	8
	SDA	CANRX ³	URXD2	GPIO	PDSR[0]	PSRR[0]	pull-up ⁵	11	E2	9



Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength / Control ¹	Slew Rate / Control ¹	Pull-up / Pull-down ²	Pin on 100 LQFP	Pin on 81 MAPBGA	Pin on 64 LQFP/QFN
Interrupts	ĪRQ7	_	_	GPIO	Low	FAST	pull-up	95	C4	58
	ĪRQ6	_	_	GPIO	Low	FAST	pull-up	94	B4	_
	ĪRQ5	_	_	GPIO	Low	FAST	pull-up	91	A4	_
	ĪRQ4		_	GPIO	Low	FAST	pull-up	90	C5	57
	ĪRQ3	_	_	GPIO	Low	FAST	pull-up	89	A5	_
	ĪRQ2		_	GPIO	Low	FAST	pull-up	88	B5	_
	ĪRQ1	SYNCA	PWM1	GPIO	High	FAST	pull-up ⁵	87	C6	56
JTAG/BDM	JTAG_EN	_	_	_	N/A	N/A	pull-down	26	J2	17
	TCLK/ PSTCLK	CLKOUT	_	_	High	FAST	pull-up ⁶	64	C7	44
	TDI/DSI		_	_	N/A	N/A	pull-up ⁶	79	B7	50
	TDO/DSO	_	_	_	High	FAST	_	80	A7	51
	TMS /BKPT	_	_	_	N/A	N/A	pull-up ⁶	76	A8	49
	TRST /DSCLK	_	_	_	N/A	N/A	pull-up ⁶	85	В6	54
Mode	CLKMOD0	_	_	_	N/A	N/A	pull-down ⁷	40	G5	24
Selection ⁷	CLKMOD1	_	_	_	N/A	N/A	pull-down ⁷	39	H5	_
	RCON/ EZPCS	_	_	_	N/A	N/A	pull-up	21	G3	16
PWM	PWM7	_	_	GPIO	PDSR[31]	PSRR[31]	_	63	D7	_
	PWM5	_	_	GPIO	PDSR[30]	PSRR[30]	_	60	E8	_
	PWM3	_	_	GPIO	PDSR[29]	PSRR[29]	_	33	J4	_
	PWM1	_	_	GPIO	PDSR[28]	PSRR[28]	_	38	J5	_

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Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength / Control ¹	Slew Rate / Control ¹	Pull-up / Pull-down ²	Pin on 100 LQFP	Pin on 81 MAPBGA	Pin on 64 LQFP/QFN
QSPI	QSPI_DIN/ EZPD	CANRX ⁴	URXD1	GPIO	PDSR[2]	PSRR[2]	_	16	F3	12
	QSPI_DOUT/ EZPQ	CANTX ⁴	UTXD1	GPIO	PDSR[1]	PSRR[1]	_	17	G1	13
	QSPI_CLK/ EZPCK	SCL	URTS1	GPIO	PDSR[3]	PSRR[3]	pull-up ⁸	18	G2	14
	QSPI_CS3	SYNCA	SYNCB	GPIO	PDSR[7]	PSRR[7]	_	12	F1	_
	QSPI_CS2	_	_	GPIO	PDSR[6]	PSRR[6]	_	13	F2	_
	QSPI_CS1	_	_	GPIO	PDSR[5]	PSRR[5]	_	19	H2	_
	QSPI_CS0	SDA	UCTS1	GPIO	PDSR[4]	PSRR[4]	pull-up ⁸	20	H1	15
Reset ⁹	RSTI	_	_	_	N/A	N/A	pull-up ⁹	96	А3	59
	RSTO	_	_	_	high	FAST	_	97	В3	60
Test	TEST	_	_	_	N/A	N/A	pull-down	5	C2	3
Timers, 16-bit	GPT3	_	PWM7	GPIO	PDSR[23]	PSRR[23]	pull-up ¹⁰	62	D8	43
	GPT2	_	PWM5	GPIO	PDSR[22]	PSRR[22]	pull-up ¹⁰	61	D9	42
	GPT1	_	PWM3	GPIO	PDSR[21]	PSRR[21]	pull-up ¹⁰	59	E9	41
	GPT0	_	PWM1	GPIO	PDSR[20]	PSRR[20]	pull-up ¹⁰	58	F7	40
Timers, 32-bit	DTIN3	DTOUT3	PWM6	GPIO	PDSR[19]	PSRR[19]	_	32	НЗ	19
	DTIN2	DTOUT2	PWM4	GPIO	PDSR[18]	PSRR[18]	_	31	J3	18
	DTIN1	DTOUT1	PWM2	GPIO	PDSR[17]	PSRR[17]	_	37	G4	23
	DTIN0	DTOUT0	PWM0	GPIO	PDSR[16]	PSRR[16]	_	36	H4	22
UART 0	UCTS0	CANRX	_	GPIO	PDSR[11]	PSRR[11]	_	6	C1	4
	URTS0	CANTX	_	GPIO	PDSR[10]	PSRR[10]	_	9	D3	7
	URXD0	_	_	GPIO	PDSR[9]	PSRR[9]	_	7	D1	5
	UTXD0	_	_	GPIO	PDSR[8]	PSRR[8]	_	8	D2	6

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1.2 Reset Signals

Table 4 describes signals used to reset the chip or as a reset indication.

Table 4. Reset Signals

Signal Name	Abbreviation	Function	I/O
Reset In		Primary reset input to the device. Asserting RSTI for at least 8 CPU clock cycles immediately resets the CPU and peripherals.	I
Reset Out	RSTO	Driven low for 1024 CPU clocks after the reset source has deasserted.	0

1.3 PLL and Clock Signals

Table 5 describes signals used to support the on-chip clock generation circuitry.

Table 5. PLL and Clock Signals

Signal Name	Abbreviation	Function	I/O
External Clock In	EXTAL	Crystal oscillator or external clock input except when the on-chip relaxation oscillator is used.	Ţ
Crystal		Crystal oscillator output except when CLKMOD1=1, then sampled as part of the clock mode selection mechanism.	0
Clock Out	CLKOUT	This output signal reflects the internal system clock.	0

1.4 Mode Selection

Table 6 describes signals used in mode selection; Table 7 describes the particular clocking modes.

Table 6. Mode Selection Signals

Signal Name	Abbreviation	Function	I/O
Clock Mode Selection	CLKMOD[1:0]	Selects the clock boot mode.	I
Reset Configuration	RCON	The Serial Flash Programming mode is entered by asserting the RCON pin (with the TEST pin negated) as the chip comes out of reset. During this mode, the EzPort has access to the flash memory which can be programmed from an external device.	
Test	TEST	Reserved for factory testing only and in normal modes of operation should be connected to VSS to prevent unintentional activation of test functions.	I

Table 7. Clocking Modes

CLKMOD[1:0]	XTAL	Configure the clock mode.
00	0	PLL disabled, clock driven by external oscillator
00	1	PLL disabled, clock driven by on-chip oscillator
01	N/A	PLL disabled, clock driven by crystal
10	0	PLL in normal mode, clock driven by external oscillator
10	1	PLL in normal mode, clock driven by on-chip oscillator
11	N/A	PLL in normal mode, clock driven by crystal

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1.5 External Interrupt Signals

Table 8 describes the external interrupt signals.

Table 8. External Interrupt Signals

Signal Name	Abbreviation	Function	I/O
External Interrupts	ĪRQ[7:1]	External interrupt sources.	I

1.6 Queued Serial Peripheral Interface (QSPI)

Table 9 describes the QSPI signals.

Table 9. Queued Serial Peripheral Interface (QSPI) Signals

Signal Name	Abbreviation	Function	I/O
QSPI Synchronous Serial Output	QSPI_DOUT	Provides the serial data from the QSPI and can be programmed to be driven on the rising or falling edge of QSPI_CLK.	0
QSPI Synchronous Serial Data Input	QSPI_DIN	Provides the serial data to the QSPI and can be programmed to be sampled on the rising or falling edge of QSPI_CLK.	1
QSPI Serial Clock	QSPI_CLK	Provides the serial clock from the QSPI. The polarity and phase of QSPI_CLK are programmable.	0
Synchronous Peripheral Chip Selects	QSPI_CS[3:0]	QSPI peripheral chip select; can be programmed to be active high or low.	0

1.7 I²C I/O Signals

Table 10 describes the I²C serial interface module signals.

Table 10. I²C I/O Signals

Signal Name	Abbreviation	Function	1/0
Serial Clock		Open-drain clock signal for the for the I ² C interface. When the bus is In master mode, this clock is driven by the I ² C module; when the bus is in slave mode, this clock becomes the clock input.	I/O
Serial Data	SDA	Open-drain signal that serves as the data input/output for the I ² C interface.	I/O



Electrical Characteristics

Table 21. Typical Active Current Consumption Specifications

Characteristic	Symbol	Typical ¹ Active (SRAM)	Typical ¹ Active (Flash)	Peak ²	Unit
1 MHz core & I/O	I _{DD}	_	3.48	_	mA
8 MHz core & I/O		7.28	13.37	19.02	
16 MHz core & I/O		12.08	25.08	35.66	
64 MHz core & I/O		40.14	54.62	85.01	
80 MHz core & I/O		49.2	64.09	100.03	
 RAM standby supply current Normal operation: V_{DD} > V_{STBY} - 0.3 V Transient condition: V_{STBY} - 0.3 V > V_{DD} > V_{SS} + 0.5 V Standby operation: V_{DD} < V_{SS} + 0.5 V 	I _{STBY}	N/. N/. N/.	A ³ N/A ³ N/A ³		μΑ mA μΑ
Analog supply current Normal operation Low-power stop	I _{DDA}	_ _	_ _	16 50	mA μA

¹ Tested at room temperature with CPU polling a status register. All clocks were off except the UART and CFM (when running from flash memory).

2.3 Thermal Characteristics

Table 22 lists thermal resistance values.

Table 22. Thermal Characteristics

	Characteristic	Symbol	Value	Unit	
100 LQFP	Junction to ambient, natural convection	Single layer board (1s)	$\theta_{\sf JA}$	53 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	$\theta_{\sf JA}$	39 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	42 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	33 ^{1,3}	°C/W
	Junction to board	_	θ_{JB}	25 ⁴	°C/W
	Junction to case	_	$\theta_{\sf JC}$	9 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ⁶	°C/W
	Maximum operating junction temperature	_	Тj	105	°C

² Peak current measured with all modules active, and default drive strength with matching load.

Due to the errata "Non-functional RAM Standby Supply" in the MCF5213 Device Errata, V_{STBY} should be connected directly to V_{DD} and cannot be used for RAM standby operation.



Table 22. Thermal Characteristics (continued)

	Characteristic	;	Symbol	Value	Unit
81 MAPBGA	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	61 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	$\theta_{\sf JA}$	35 ^{2,3}	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	50 ^{2,3}	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	31 ^{2,3}	°C/W
	Junction to board	_	θ_{JB}	20 ⁴	°C/W
	Junction to case	_	θJC	12 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ⁶	°C/W
	Maximum operating junction temperature	_	T _j	105	°C
64 LQFP	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	62 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	43 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Single layer board (1s)	θ_{JMA}	50 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	36 ^{1,3}	°C/W
	Junction to board	_	θ_{JB}	26 ⁴	°C/W
	Junction to case	_	θJC	9 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ⁶	°C/W
	Maximum operating junction temperature	_	T _j	105	°C
64 QFN	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	68 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	24 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Single layer board (1s)	θ_{JMA}	55 ^{1,3}	°C/W
	Junction to ambient (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	19 ^{1,3}	°C/W
	Junction to board	_	θ_{JB}	8 ⁴	°C/W
	Junction to case (bottom)	_	θJC	0.6 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	3 ⁶	°C/W
	Maximum operating junction temperature	_	T _j	105	°C

 $[\]theta_{JA}$ and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

² Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.

³ Per JEDEC JESD51-6 with the board JESD51-7) horizontal.

⁴ Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

⁶ Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.



Table 27. PLL Electrical Specifications (continued)

(V_{DD} and V_{DDPLL} = 2.7 to 3.6 V, $V_{SS} = V_{SSPLL} = 0 \text{ V}$)

Characteristic	Symbol	Min	Max	Unit
Frequency un-LOCK range	f _{UL}	-1.5	1.5	% f _{ref}
Frequency LOCK range	f _{LCK}	-0.75	0.75	% f _{ref}
CLKOUT period jitter ^{4, 5, 8, 9} , measured at f _{SYS} Max • Peak-to-peak (clock edge to clock edge) • Long term (averaged over 2 ms interval)	C _{jitter}		10 .01	% f _{sys}
On-chip oscillator frequency	f _{oco}	7.84	8.16	MHz

¹ All internal registers retain data at 0 Hz.

2.8 General Purpose I/O Timing

GPIO can be configured for certain pins of the QSPI, DDR Control, timer, UART, and Interrupt interfaces. When in GPIO mode, the timing specification for these pins is given in Table 28 and Figure 5.

The GPIO timing is met under the following load test conditions:

- 50 pF / 50 Ω for high drive
- $25 \text{ pF} / 25 \Omega$ for low drive

Table 28. GPIO Timing

NUM	Characteristic	Symbol	Min	Max	Unit
G1	CLKOUT High to GPIO Output Valid	t _{CHPOV}	_	10	ns
G2	CLKOUT High to GPIO Output Invalid	t _{CHPOI}	1.5	_	ns
G3	GPIO Input Valid to CLKOUT High	t _{PVCH}	9	_	ns
G4	CLKOUT High to GPIO Input Invalid	t _{CHPI}	1.5	_	ns

² Depending on packaging; see Table 2.

³ Loss of Reference Frequency is the reference frequency detected internally, which transitions the PLL into self clocked mode.

Self clocked mode frequency is the frequency at which the PLL operates when the reference frequency falls below f_{LOR} with default MFD/RFD settings.

⁵ This parameter is characterized before qualification rather than 100% tested.

⁶ Proper PC board layout procedures must be followed to achieve specifications.

This specification applies to the period required for the PLL to relock after changing the MFD frequency control bits in the synthesizer control register (SYNCR).

Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{sys}. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via V_{DDPLL} and V_{SSPLL} and variation in crystal oscillator frequency increase the C_{jitter} percentage for a given interval.

⁹ Based on slow system clock of 40 MHz measured at f_{svs} max.



Electrical Characteristics

Figure 7 shows timing for the values in Table 30 and Table 31.

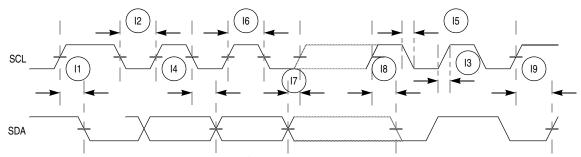


Figure 7. I²C Input/Output Timings

2.11 Analog-to-Digital Converter (ADC) Parameters

Table 32 lists specifications for the analog-to-digital converter.

Table 32. ADC Parameters¹

Name	Characteristic	Min	Typical	Max	Unit
V _{REFL}	Low reference voltage	V_{SS}	_	V _{REFH}	V
V _{REFH}	High reference voltage	V _{REFL}	_	V_{DDA}	V
V _{DDA}	ADC analog supply voltage	3.0	3.3	3.6	V
V _{ADIN}	Input voltages	V _{REFL}	_	V _{REFH}	V
RES	Resolution	12	_	12	Bits
INL	Integral non-linearity (full input signal range) ²	_	±2.5	±3	LSB ³
INL	Integral non-linearity (10% to 90% input signal range) ⁴	_	±2.5	±3	LSB
DNL	Differential non-linearity	_	-1 < DNL < +1	<+1	LSB
	Monotonicity		GUARAN	ITEED	•
f _{ADIC}	ADC internal clock	0.1	_	5.0	MHz
R _{AD}	Conversion range	V _{REFL}	_	V _{REFH}	V
t _{ADPU}	ADC power-up time ⁵	_	6	13	t _{AIC} cycles ⁶
t _{REC}	Recovery from auto standby	_	0	1	t _{AIC} cycles
t _{ADC}	Conversion time	_	6	_	t _{AIC} cycles
t _{ADS}	Sample time	_	1	_	t _{AIC} cycles
C _{ADI}	Input capacitance	_	See Figure 8	_	pF
X _{IN}	Input impedance	_	See Figure 8	_	W
I _{ADI}	Input injection current ⁷ , per pin	_	_	3	mA
I _{VREFH}	V _{REFH} current	_	0	_	m
V _{OFFSET}	Offset voltage internal reference	_	±8	±15	mV
E _{GAIN}	Gain error (transfer path)	.99	1	1.01	_
V _{OFFSET}	Offset voltage external reference	_	±3	TBD	mV
SNR	Signal-to-noise ratio	_	62 to 66	_	dB



Electrical Characteristics

2.13 DMA Timers Timing Specifications

Table 33 lists timer module AC timings.

Table 33. Timer Module AC Timing Specifications

Name	Characteristic ¹	Min	Max	Unit
T1	DTIN0 / DTIN1 / DTIN2 / DTIN3 cycle time	$3 \times t_{CYC}$	_	ns
T2	DTIN0 / DTIN1 / DTIN2 / DTIN3 pulse width	$1 \times t_{CYC}$	_	ns

¹ All timing references to CLKOUT are given to its rising edge.

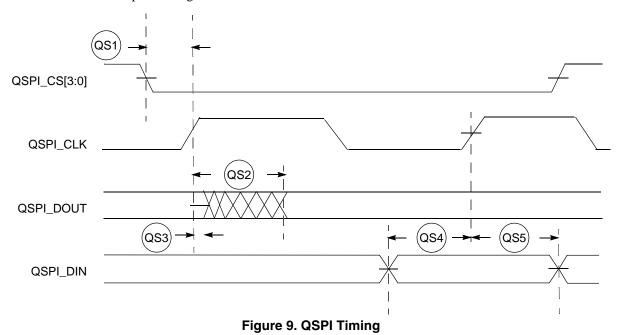
2.14 QSPI Electrical Specifications

Table 34 lists QSPI timings.

Table 34. QSPI Modules AC Timing Specifications

Name	Characteristic	Min	Max	Unit
QS1	QSPI_CS[3:0] to QSPI_CLK	1	510	t _{CYC}
QS2	QSPI_CLK high to QSPI_DOUT valid	_	10	ns
QS3	QSPI_CLK high to QSPI_DOUT invalid (Output hold)	2	_	ns
QS4	QSPI_DIN to QSPI_CLK (Input setup)	9	_	ns
QS5	QSPI_DIN to QSPI_CLK (Input hold)	9	_	ns

The values in Table 34 correspond to Figure 9.



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2.16 **Debug AC Timing Specifications**

Table 36 lists specifications for the debug AC timing parameters shown in Figure 15.

Table 36. Debug AC Timing Specification

Num	Characteristic	66/80	Units	
Num	Onaracteristic -		Max	Onits
D1	PST, DDATA to CLKOUT setup	4	_	ns
D2	CLKOUT to PST, DDATA hold	1.5	_	ns
D3	DSI-to-DSCLK setup	1 × t _{CYC}	_	ns
D4 ¹	DSCLK-to-DSO hold	4 × t _{CYC}	_	ns
D5	DSCLK cycle time	5 × t _{CYC}	_	ns
D6	BKPT input data setup time to CLKOUT rise	4	_	ns
D7	BKPT input data hold time to CLKOUT rise	1.5	_	ns
D8	CLKOUT high to BKPT high Z	0.0	10.0	ns

DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of CLKOUT.

Figure 14 shows real-time trace timing for the values in Table 36.

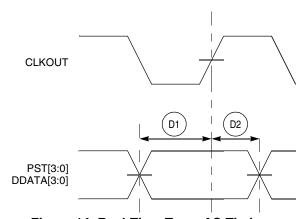
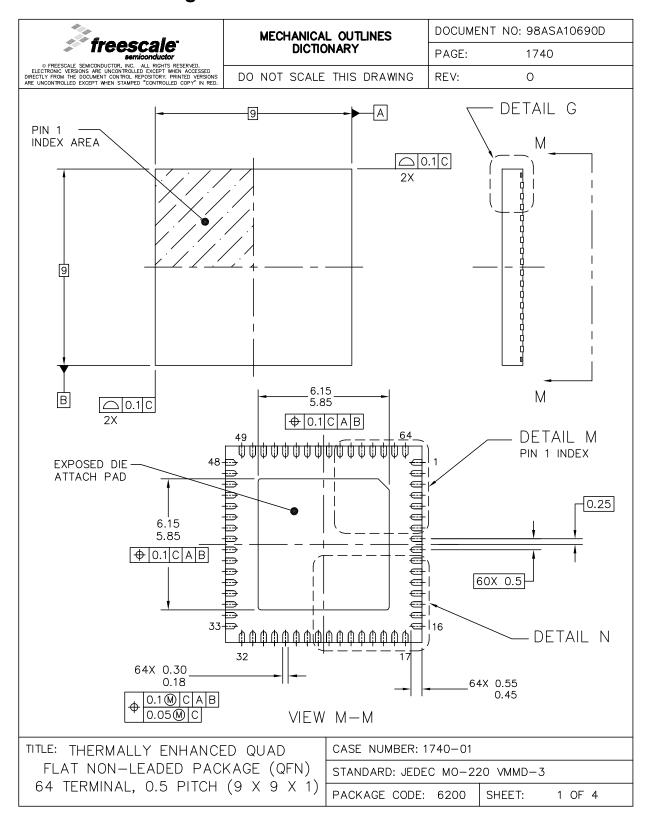


Figure 14. Real-Time Trace AC Timing

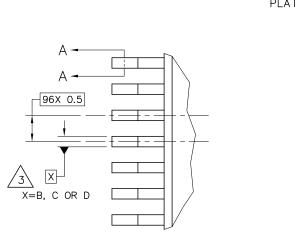
Mechanical Outline Drawings

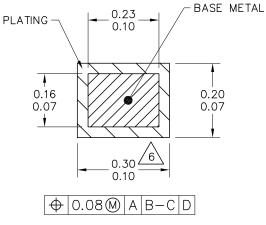
3.2 64 QFN Package

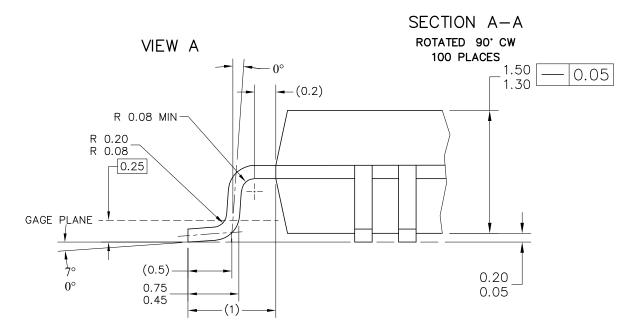




Mechanical Outline Drawings







VIEW B

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		STANDARD: NO	N-JEDEC	



Revision History

4 Revision History

Table 37. Revision History

Revision	Description
2	 Formatting, layout, spelling, and grammar corrections. Added revision history. Corrected signal names in block diagram to match those in signal description table. Added the following footnote to the MCF5211 FlexCAN entry:
3	 Formatting, layout, spelling, and grammar corrections. Synchronized the "Pin Functions by Primary and Alternate Purpose" table in this document and the reference manual. Restructured the part number summary table to include full orderable parts, and changed its name (was "Part Number Summary", is "Orderable Part Number Summary"). Updated the family configurations table to show that FlexCAN is not available on the MCF5212. Added specifications for V_{LVD} and V_{LVDHYS} to the "DC electrical specifications" table.





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Freescale Semiconductor 55